

## **MOSFET** - Power, Single, **N-Channel**

### 40 V, 0.92 mΩ, 300 A

## NTMJS1D0N04C

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- LFPAK-E Package, Industry Standard
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain	Steady	T <sub>C</sub> = 25 °C	I <sub>D</sub>	300	Α
Current R <sub>0JC</sub> (Notes 1, 3)		T <sub>C</sub> = 100 °C		212	
Power Dissipation	State	T <sub>C</sub> = 25 °C	$P_{D}$	166	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100 °C		83	
Continuous Drain		T <sub>A</sub> = 25 °C	I <sub>D</sub>	46	Α
Current R <sub>θJA</sub> (Notes 1, 2, 3)	Steady State	T <sub>A</sub> = 100 °C		32	
Power Dissipation		T <sub>A</sub> = 25 °C	$P_{D}$	3.9	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100 °C		1.9	
Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to + 175	°C	
Source Current (Body Diode)		IS	158	Α	
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 34 A)		E <sub>AS</sub>	578	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

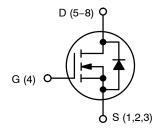
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.9	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	36	

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

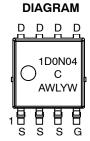
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	0.92 mΩ @ 10 V	300 A



**N-CHANNEL MOSFET** 



CASE 760AA



**MARKING** 

1D0N04C = Specific Device Code = Assembly Location

= Wafer Lot WL = Year = Work Week

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu A$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				16		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>					10	^
	$V_{DS} = 40 \text{ V}$ $T_{J} = 1$		T <sub>J</sub> = 125 °C			100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 190 μΑ	2.5		3.5	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		0.76	0.92	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> =15 V, I <sub>D</sub> = 50 A			190		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			6100		
Output Capacitance	C <sub>OSS</sub>				3400		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				70		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V; I <sub>D</sub> = 50 A			86		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V; I <sub>D</sub> = 50 A			18		]
Gate-to-Source Charge	$Q_{GS}$				28		nC
Gate-to-Drain Charge	$Q_GD$				14		1
Plateau Voltage	$V_{GP}$				4.9		V
SWITCHING CHARACTERISTICS (Note 5)	)					•	-
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 32 V, $I_{D}$ = 50 A, $R_{G}$ = 2.5 $\Omega$			54		
Rise Time	t <sub>r</sub>				162		- ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				227		
Fall Time	t <sub>f</sub>				173		
DRAIN-SOURCE DIODE CHARACTERIST	ics						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C		0.8	1.2	\ , .
	I <sub>S</sub> = 50 A	T <sub>J</sub> = 125 °C		0.65		· V	
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, dIS/dt = 100 A/ $\mu$ s, I <sub>S</sub> = 50 A			91		
Charge Time	t <sub>a</sub>				42		ns
Discharge Time	t <sub>b</sub>				49		1
Reverse Recovery Charge	Q <sub>RR</sub>				159		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

<sup>5.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

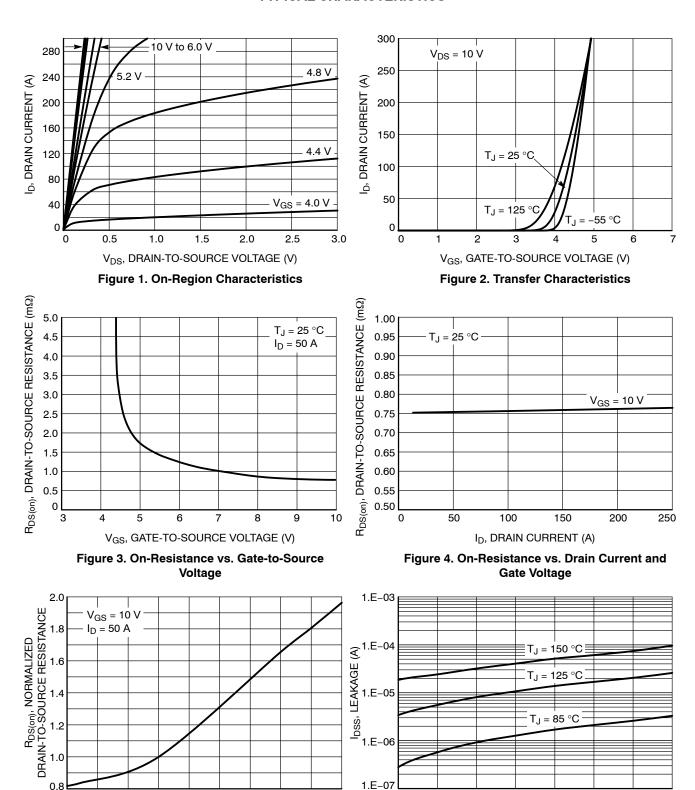


Figure 5. On-Resistance Variation with Temperature

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

75

100

125

150

175

10

15

-50 -25

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

25

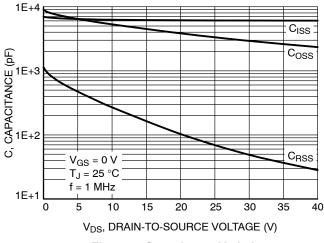
30

35

40

20

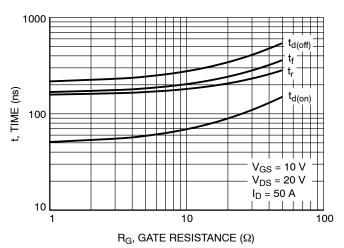
#### **TYPICAL CHARACTERISTICS**



V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) 8 7 6  $Q_{GS}$  $Q_{GD}$ 5 3  $V_{DS} = 20 V$  $T_J = 25 \,^{\circ}C$  $I_{D} = 50 \text{ A}$ 10 20 50 70 Q<sub>G</sub>, GATE CHARGE (nC)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source Voltage vs. Charge



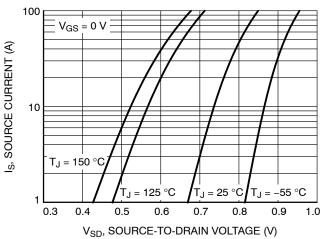
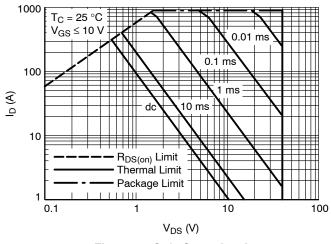


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



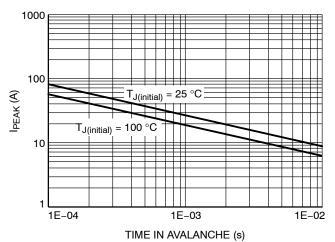


Figure 11. Safe Operating Area

Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

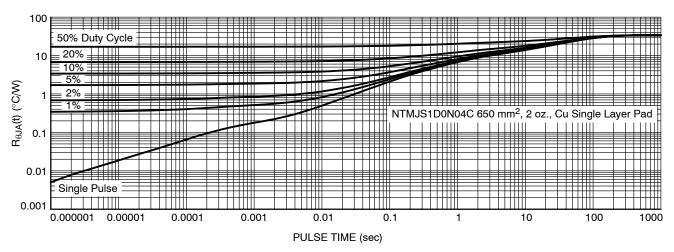


Figure 13. Thermal Characteristics

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMJS1D0N04CTWG	1D0N04 C	LFPAK8 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **REVISION HISTORY**

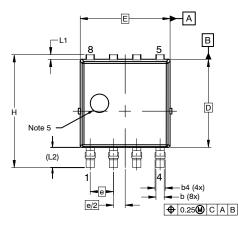
Revision	Description of Changes	Date	
0	Initial document release.	11/26/2018	
1	Document rebranded to <b>onsemi</b> format.	8/27/2025	

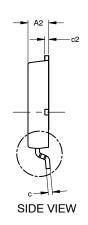




# **LFPAK8 4.90x4.80x1.12MM**, **1.27P**CASE 760AA ISSUE D

**DATE 22 APR 2024** 

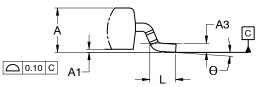


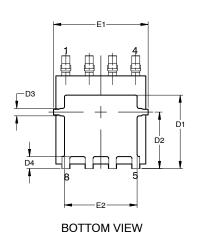


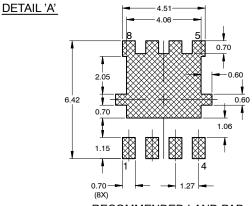
#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. OPTIONAL MOLD FEATURE.









RECOMMENDED LAND PAD

\*FOR ADDITIONAL INFORMATION ON OUR

MANUAL, SOLDERRM/D.

PB-FREE STRATEGY AND SOLDERING DETAILS.

PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE

**MILLIMETERS** MIN NOM DIM 1.10 1.20 1.30 Α A1 0.00 0.08 0.15 Α2 1.10 1.15 1.20 АЗ 0.25 BSC b 0.40 0.45 0.50 0.45 0.55 0.65 b4 0.19 0.22 0.25 С c2 0.19 0.22 0.25 4.70 4.80 4.90 D D1 3.80 4.00 4.20 2.98 D2 3.08 3.18 D3 0.30 0.40 0.50 D4 0.55 0.65 0.75 4.80 4.90 5.00 Ε E1 5.05 5.15 5.25 E2 3.91 3.96 4.01 1.27 BSC е 0.635 BSC e/2 Н 6.00 6.15 6.30 L 0.50 0.70 0.90 0.25 0.35 L1 0.15 L2 1.10 REF 4° θ

## GENERIC MARKING DIAGRAM\*



XXXXXX = Specific Device Code

= Work Week

A = Assembly Location

WL = Wafer Lot Y = Year

W

\*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:

98AON82475G

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DESCRIPTION:

LFPAK8 4.90x4.80x1.12MM, 1.27P

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